



BSI Standards Publication

Potentiometers for use in electronic equipment

Part 5: Sectional specification —
Single-turn rotary low-power
wirewound and non-wirewound
potentiometers

National foreword

This British Standard is the UK implementation of EN 60393-5:2016. It is identical to IEC 60393-5:2015. It supersedes BS QC 410300:1992 which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/40X, Capacitors and resistors for electronic equipment.

A list of organizations represented on this committee can be obtained on request to its secretary.

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English Version

Potentiometers for use in electronic equipment - Part 5:
Sectional specification - Single-turn rotary low-power wirewound
and nonwirewound potentiometers
(IEC 60393-5:2015)

Potentiomètres utilisés dans les équipements électroniques
- Partie 5: Spécification intermédiaire - Potentiomètres de
faible puissance, bobinés et non bobinés, rotatifs, monotour
(IEC 60393-5:2015)

Potentiometer zur Verwendung in Geräten der Elektronik -
Teil 5: Rahmenspezifikation - Niedrigbelastbare
drahtgewickelte und nichtdrahtgewickelte Einfach-
Drehpotentiometer
(IEC 60393-5:2015)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

European foreword

The text of document 40/2408/FDIS, future edition 3 of IEC 60393-5, prepared by IEC/TC 40 "Capacitors and resistors for electronic equipment" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 60393-5:2016.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2016-10-18
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2019-01-18

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Endorsement notice

The text of the International Standard IEC 60393-5:2015 was approved by CENELEC as a European Standard without any modification.

Annex ZA
 (normative)

**Normative references to international publications
 with their corresponding European publications**

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60062	-	Marking codes for resistors and capacitors	EN 60062	-
IEC 60068-1	2013	Environmental testing -- Part 1: General and guidance	EN 60068-1	2014
IEC 60068-2-1	2007	Environmental testing -- Part 2-1: Tests Test A: Cold	EN 60068-2-1	2007
IEC 60068-2-2	2007	Environmental testing -- Part 2-2: Tests Test B: Dry heat	EN 60068-2-2	2007
IEC 60393-1	2008	Potentiometers for use in electronic equipment -- Part 1: Generic specification	EN 60393-1	2009
IEC 60915	-	Capacitors and resistors for use in electronic equipment - Preferred dimensions of shaft ends, bushes and for the mounting of single-hole, bush-mounted, shaft-operated electronic components	EN 60915	-
IEC 61193-2	2007	Quality assessment systems -- Part 2: Selection and use of sampling plans for inspection of electronic components and packages	EN 61193-2	2007

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

POTENTIOMETERS FOR USE IN ELECTRONIC EQUIPMENT –**Part 5: Sectional specification – Single-turn rotary low-power
wirewound and non-wirewound potentiometers**

FOREWORD

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International Standard IEC 60393-5 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This third edition cancels and replaces the second edition published in 1992 and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) revision of the information on the assessment level EZ and FZ (zero nonconforming);
- b) complete editorial revision.

The text of this standard is based on the following documents:

FDIS	Report on voting
40/2408/FDIS	40/2423/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This International Standard is to be used in conjunction with IEC 60393-1:2008.

A list of all parts in the IEC 60363 series, published under the general title *Potentiometers for use in electronic equipment*, can be found on the IEC website.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

POTENTIOMETERS FOR USE IN ELECTRONIC EQUIPMENT –

Part 5: Sectional specification – Single-turn rotary low-power wirewound and non-wirewound potentiometers

1 General

1.1 Scope

This part of IEC 60393 applies to single-turn rotary low-power wirewound and non-wirewound potentiometers, with a rated dissipation less than to 10 W. These potentiometers are primarily intended for use in electronic equipment.

This part of IEC 60393 prescribes preferred ratings and characteristics and selects from IEC 60393-1, appropriate quality assessment procedures, tests and measuring methods. It provides general performance requirements for this type of potentiometer.

This standard gives the minimum performance requirements and test severities.

1.2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60062, *Marking codes for resistors and capacitors*

IEC 60068-1:2013, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-1:2007, *Environmental testing – Part 2-1: Tests – Test A: Cold*

IEC 60068-2-2:2007, *Environmental testing – Part 2-2: Tests – Test B: Dry heat*

IEC 60393-1:2008, *Potentiometers for use in electronic equipment – Part 1: Generic specification*

IEC 60915, *Capacitors and resistors for use in electronic equipment – Preferred dimensions of shaft ends, bushes and for the mounting of single-hole, bush-mounted, shaft-operated electronic components*

IEC 61193-2:2007, *Quality assessment systems – Part 2: Selection and use of sampling plans for inspection of electronic components and packages*

1.3 Information to be given in a detail specification

1.3.1 General

Detail specifications shall be derived from the relevant blank detail specification.

Detail specifications shall not specify requirements inferior to those of the generic, sectional or blank detail specification. When more severe requirements are included, they shall be listed in a subclause of the detail specification and indicated in the test schedules, for example by an asterisk.

The information given in 1.3.3 and 1.3.4 may, for convenience, be presented in tabular form.

The following information shall be given in each detail specification and the values quoted shall preferably be selected from those given in the appropriate clause of this sectional specification.

1.3.2 Outline drawing and dimensions

The detail specification shall incorporate an illustration of the potentiometer being specified. Where space is insufficient to show the detail dimensions required for inspection purposes, such dimensions shall appear on a drawing forming an annex to the detail specification, as shown in Figure 1.

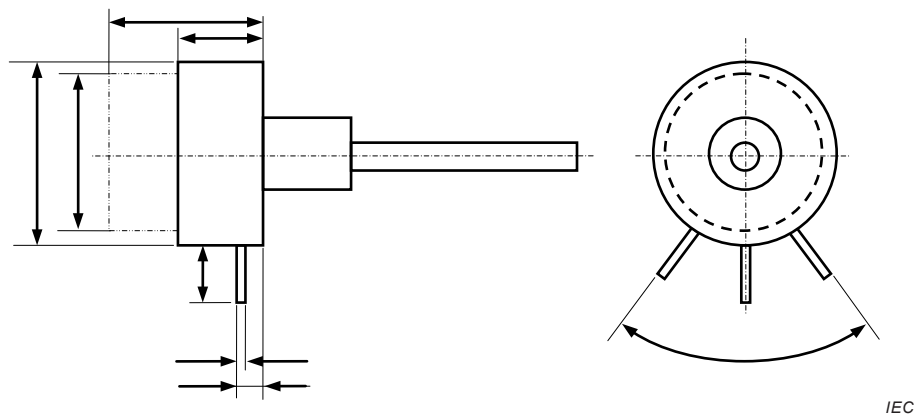


Figure 1 – Outline drawing and dimensions

The drawing shall give the following details:

- the dimensions of the shaft and bush. These may be given either on the outline drawing or by reference to IEC 60915;
- any locating devices;
- the total mechanical travel;
- the effective electrical travel;
- the angle of ineffective mechanical travel;
- the switch angle (if applicable);
- the dimensions of the switch, if fitted, and the location of terminations;
- the dimensions which shall be measured in accordance with IEC 60393-1:2008, 4.4.2;
- any other dimensional information which will adequately describe the potentiometer.

All dimensions shall preferably be stated in millimetres, however, when the original dimensions are given in inches, the converted metric dimensions in millimetres shall be added.

When the potentiometer is not designed for use on printed boards, this shall be clearly indicated in the detail specification.

1.3.3 Mounting

The detail specification shall specify the method of mounting to be applied for the voltage proof and the insulation resistance tests and for the application of the vibration and shock tests. The potentiometers shall be mounted by their normal means, but the design may be such that special mounting fixtures are required. In this case, the detail specification shall describe the mounting fixtures that shall be used for the voltage proof and the insulation

resistance tests and for the application of the vibration and shock tests. For the latter tests the mounting shall be such that there shall be no parasitic vibration.

1.3.4 Style

See IEC 60393-1:2008, 2.2.2.

The style shall be presented by a double-letter code, e.g. AB, which is arbitrarily chosen for each detail specification.

The style designation, therefore, has no meaning unless the number of the detail specification is also given.

1.3.5 Resistance law

See 2.1.6.

1.3.6 Ratings and characteristics

1.3.6.1 General

The ratings and characteristics shall be in accordance with the relevant clauses of this specification together with the following:

1.3.6.2 Nominal total resistance range

See IEC 60393-1:2008, 2.3.2

When products approved according to the detail specification have different ranges, the following statement should be added:

“The range of values available in each style is given in the register of approvals, available for example on the website <http://www.iecq.org>”.

The qualified products list “QPL” style is given in the register of approvals, available for example on the website stated above.

1.3.7 Marking

The detail specification shall specify the content of the marking on the potentiometer and on the package. Deviations from 1.4 of this sectional specification shall be specifically stated.

1.3.8 Ordering information

The detail specification shall indicate that the following information, in clear or in coded form, is required when ordering:

- a) nominal total resistance and tolerance on nominal total resistance;
- b) resistance law (if other than linear);
- c) number and issue reference of the detail specification and style reference;
- d) shaft and bush dimensions, if not implicit in the style reference.

1.3.9 Additional information

The detail specification may include information which is not required to be verified by the inspection procedure, such as circuit diagrams, curves, drawings and notes needed for the clarification of the detail specification.

1.4 Marking

1.4.1 General

When coding is used for nominal resistance, tolerance and date of manufacture, the method shall be selected from those given in IEC 60062.

The information given in the marking is normally selected from the following list; the relative importance of each item is indicated by its position in the list:

- a) nominal total resistance;
- b) tolerance on nominal total resistance;
- c) resistance law (if other than linear);
- d) detail specification and style reference;
- e) year and month (or week) of manufacture;
- f) details of shaft and bush (if not implicit in d) above). This may be in code form;
- g) manufacturer's name and/or trademark;
- h) switch rated voltage (a.c. and d.c. ratings when appropriate);
- i) switch rated current (a.c. and d.c. ratings when appropriate);
- j) corresponding terminals (in the case of double pole switches), and terminals for connection to the mains supply;
- k) manufacturer's type and designation.

1.4.2 Marking for potentiometers

The potentiometer shall be clearly marked with a) and b) of 1.4.1 and with as many of the remaining items as is practicable. Any duplication of information in the marking of the potentiometer should be avoided.

The switch, if fitted, shall be clearly marked with h), i) and j) of 1.4.1.

1.4.3 Marking for packaging

The package containing the potentiometer(s) shall be clearly marked with a) to g) and, if a switch is fitted to the potentiometer, with h) and i) of 1.4.1, and with the information below.

- a) quantity
- b) country origin

1.4.4 Additional marking

Any additional marking shall be so applied that no confusion can arise.

2 Preferred ratings, characteristics and test severities

2.1 Preferred characteristics

2.1.1 General

The values given in the detail specification shall preferably be selected from the following:

2.1.2 Preferred climatic categories

The potentiometers covered by this specification are classified into climatic categories according to the general rules given in IEC 60068-1:2013, Annex A.

The lower and upper category temperature and the duration of the damp heat, steady state test shall be chosen from the following:

Lower category temperature:	–65 °C, –55 °C, –40 °C, –25 °C and –10 °C.
Upper category temperature	+70 °C, +85 °C, +100 °C, +125 °C and +155 °C.
Duration of the damp heat, steady state test:	4, 10, 21 and 56 days.

The severities for the cold and dry heat tests are the lower and upper category temperatures respectively. Because of the construction of some potentiometers these temperatures will occur between two of the preferred temperatures given in IEC 60068-2-1:2007 and IEC 60068-2-2:2007. In this case the nearest preferred temperature within the actual temperature range of the potentiometer shall be chosen for this severity.

2.1.3 Temperature coefficients and temperature characteristics of resistance

The limits of change in resistance for the temperature characteristics of resistance test are given in Table 1 (for non-wirewound potentiometers) and in Table 2 (for wirewound potentiometers).

Each line in the table gives the preferred temperature coefficients and corresponding temperature characteristics for 20 °C to 70 °C and limits of resistance change in resistance for the measurement of the temperature characteristics of resistance (see IEC 60393-1:2008, 4.14) on the basis of the category temperature ranges of 2.1.2.

Different portions of the resistance range may be covered by different temperature coefficients (or characteristics) of resistance although they appear in a single detail specification.

If measurements at additional temperatures are required, they shall be called for in the detail specification.

Table 1 – Temperature coefficients and temperature characteristics of resistance for non-wirewound potentiometers

Temperature coefficients of resistance $10^{-6}/K$	Temperature characteristics of resistance %	Temperature characteristics of resistance (limits of resistance change in percentage)								
		%								
		Reference temperature/ Lower category temperature °C					Reference temperature/ Upper category temperature °C			
20 °C/70 °C		+20/ –65	+20/ –55	+20/ –40	+20/ –25	+20/ –10	20/85 ^a	20/100	20/125	20/155
–800/ –2 500	–4/ –12,5	+6,8/ +21,3	+6/ +18,75	+4,8/ +15	+3,6/ +11,3	+2,4/ +7,5	–5,2/ –16,25	–6,4/ –20	–8,4/ –26,25	–10,8/ –33,75
–400/ –1 000	–2/ –5	+3,4/ +8,5	+3/ +7,5	+2,4/ +6	+1,8/ +4,5	+1,2/ +3	–2,6/ –6,5	–3,2/ –8	–4,2/ –10,5	–5,4/ –13,5
–150/ –600	–0,75/ –3	+1,3/ +5,1	+1,13/ +4,5	+0,9/ +3,6	+0,68/ +2,7	+0,45/ +1,8	–0,98/ –3,9	–1,2/ –4,8	–1,58/ –6,3	–2,02/ –8,2
±1 000	±5	±8,5	±7,5	±6	±4,5	±3	±6,5	±8	±10,5	±13,5
±500	±2,5	±4,3	±3,75	±3	±2,25	±1,5	±3,25	±4	±5,25	±6,75
±250	±1,25	±2,15	±1,88	±1,5	±1,13	±0,75	±1,62	±2	±2,62	±3,38
±150	±0,75	±1,3	±1,15	±0,9	±0,68	±0,45	±0,98	±1,2	±1,6	±2,05
±100	±0,5	±0,85	±0,75	±0,6	±0,45	±0,3	±0,65	±0,8	±1,05	±1,35
±50	±0,25	±0,43	±0,375	±0,3	±0,23	±0,15	±0,325	±0,4	±0,525	±0,675

^a Potentiometers having an upper category temperature of 85 °C need not be measured between 20 °C and 70 °C.

Table 2 – Temperature coefficients and temperature characteristics of resistance for wirewound potentiometers

Temperature coefficients of resistance $10^{-6}/K$	Temperature characteristics of resistance %	Temperature characteristics of resistance (limits of resistance change in percentage)								
		Reference temperature/ Lower category temperature					Reference temperature/ Upper category temperature			
		°C					°C			
20 °C/70 °C		+20/-65	+20/-55	+20/-40	+20/-25	+20/-10	20/85 ^a	20/100	20/125	20/155
+600/-200	-1/+3	-5,1/+1,7	-4,5/+1,5	-3,6/+1,2	-2,7/+0,9	-1,8/+0,6	+3,9/-1,3	+4,8/-1,6	+6,3/-2,1	+8,1/-2,7
±250	±1,25	±2,15	±1,88	±1,5	±1,13	±0,75	±1,62	±2	±2,62	±3,38
±150	±0,75	±1,3	±1,15	±0,9	±0,68	±0,45	±0,98	±1,2	±1,6	±2,05
±100	±0,5	±0,85	±0,75	±0,6	±0,45	±0,3	±0,65	±0,8	±1,05	±1,35
±50	±0,25	±0,43	±0,375	±0,3	±0,23	±0,15	±0,325	±0,4	±0,525	±0,675
±25	±0,125	±0,215	±0,188	±0,15	±0,113	±0,075	±0,162	±0,2	±0,262	±0,338

^a Potentiometers having an upper category temperature of 85 °C need not be measured between 20 °C and 70 °C.

2.1.4 Limits for change in resistance or output voltage ratio

The preferred combinations of limits for change in resistance or output voltage ratio in each of the tests listed in the heading of Table 3 are as indicated in the lines of the table.

Table 3 – Preferred combination of limits

Stability class %	4.38 Climatic sequence	4.34 Change of temperature	4.30 Robustness of terminals	4.22 Thrust and pull on shaft	4.35 Vibration
	4.39 Damp heat, steady state		4.33 Resistance to soldering heat	4.34 Change of temperature	4.37 Shock
	4.40 Mechanical endurance		4,35 Vibration		
	4.43.2 Electrical endurance at 70 °C		4.37 Shock		
	4.43.3 Electrical endurance at upper category temperature				
	ΔR between terminals <u>a</u> and <u>c</u> ^b			$\Delta \frac{U_{ab}}{U_{ac}}$ ^a	$\Delta \frac{U_{ab}}{U_{ac}}$ ^a
Non-wirewound potentiometers					
20	$\pm(20 \% R + 0,5 \Omega)$	$\pm(5 \% R + 0,1 \Omega)$	$\pm(5 \% R + 0,1 \Omega)$	$\pm 5 \%$	$\pm 5 \%$
15	$\pm(15 \% R + 0,5 \Omega)$	$\pm(5 \% R + 0,1 \Omega)$	$\pm(3 \% R + 0,1 \Omega)$	$\pm 3 \%$	$\pm 3 \%$
10	$\pm(10 \% R + 0,5 \Omega)$	$\pm(3 \% R + 0,1 \Omega)$	$\pm(2 \% R + 0,1 \Omega)$	$\pm 2 \%$	$\pm 2 \%$
5	$\pm(5 \% R + 0,1 \Omega)$	$\pm(2 \% R + 0,1 \Omega)$	$\pm(1 \% R + 0,1 \Omega)$	$\pm 1 \%$	$\pm 1 \%$
2	$\pm(2 \% R + 0,1 \Omega)$	$\pm(1 \% R + 0,05 \Omega)$	$\pm(0,5 \% R + 0,05 \Omega)$	$\pm 0,5 \%$	$\pm 0,5 \%$
Wirewound potentiometers					
5	$\pm(5 \% R + 0,1 \Omega)$	$\pm(2 \% R + 0,1 \Omega)$	$\pm(1 \% R + 0,1 \Omega)$	$\pm 1 \%$	$\pm 1 \%$
3	$\pm(3 \% R + 0,1 \Omega)$	$\pm(2 \% R + 0,1 \Omega)$	$\pm(1 \% R + 0,05 \Omega)$	$\pm 1 \%$	$\pm 1 \%$
2	$\pm(2 \% R + 0,1 \Omega)$	$\pm(1 \% R + 0,1 \Omega)$	$\pm(0,5 \% R + 0,05 \Omega)$	$\pm 0,5 \%$	$\pm 0,5 \%$
The subclause numbers in the table refer to IEC 60393-1:2008.					
^a The change in the output voltage ratio $\Delta \frac{U_{ab}}{U_{ac}}$ shall be expressed in percent of the total applied voltage.					
^b ΔR indicates the value of change in resistance.					

2.1.5 Limits for insulation resistance

The preferred limits for insulation resistance shall be 1 G Ω minimum or, after humidity tests, 100 M Ω .

2.1.6 Limits for resistance law

The preferred measuring points and associated values of the output ratio for resistance laws are as follows:

a) non-wirewound potentiometers, see Table 4.

Table 4 – Preferred measuring points and values of output ratio for non-wirewound potentiometers

Resistance law	% of effective electrical travel	Output ratio $\frac{U_{ab}}{U_{ac}}$ %
linear (B)	47 to 53	$R < 0,22 \text{ M}\Omega$: 40 to 60 $R \geq 0,22 \text{ M}\Omega$: 35 to 65
logarithmic (A)	30 to 36 64 to 70	1,5 to 8 10 to 40
reverse logarithmic (C)	30 to 36 64 to 70	60 to 90 92 to 98,5

b) wirewound potentiometers, see Table 5.

Table 5 – Preferred measuring points and values of output ratio for wirewound potentiometers

Resistance law	% of effective electrical travel $\pm 1^\circ$	Output ratio $\frac{U_{ab}}{U_{ac}}$ %
linear (B)	33 1/3 50 66 2/3	33 1/3 \pm 2,5 50 \pm 2,5 66 2/3 \pm 2,5
logarithmic (A)	25 50	12,5 \pm 5 29 \pm 5
reverse logarithmic (C)	25 50	37,5 \pm 5 70,5 \pm 5

2.1.7 Limits for starting torque

Limits for starting torque are as follows.

- a) At the standard conditions for test:
- without shaft seal: 3,5 mN·m to 50 mN·m
 - with shaft seal: 3,5 mN·m to 100 mN·m
- b) At lower category temperature:
- without shaft seal: 3,5 mN·m to 150 mN·m
 - with shaft seal: 3,5 mN·m to 300 mN·m

2.1.8 Limits for switch torque

Limits for starting torque are as follows.

- a) At the standard conditions for test:
- a maximum of 200 mN·m.
- b) At lower category temperature:
- a maximum of 400 mN·m.

2.2 Preferred values of ratings

2.2.1 General

The values given in detail specifications shall preferably be selected from the following:

2.2.2 Nominal total resistance

See IEC 60393-1:2008, 2.3.2.

2.2.3 Tolerances on nominal total resistance

The preferred tolerances on nominal total resistance are

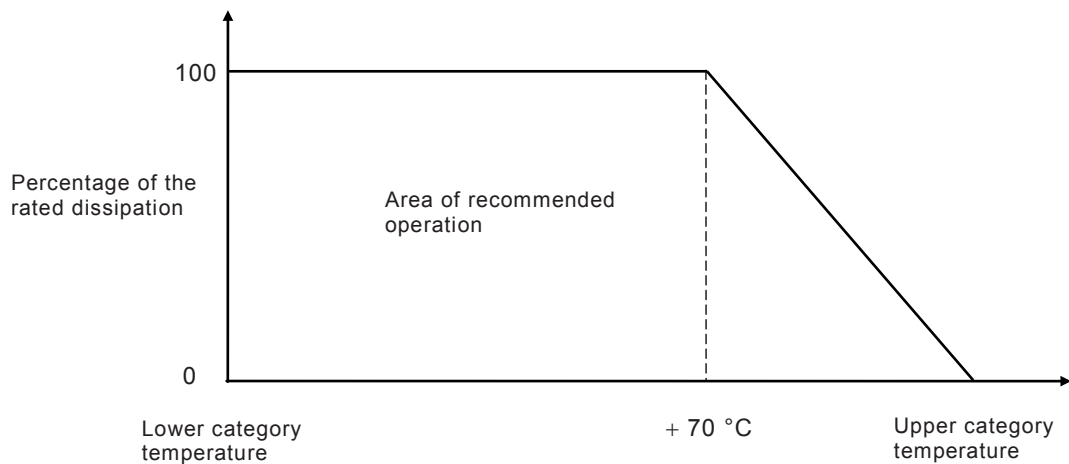
- non-wirewound types: $\pm 30\%$, $\pm 20\%$, $\pm 10\%$ and $\pm 5\%$
- wirewound types: $\pm 10\%$ and $\pm 5\%$.

2.2.4 Rated dissipation

The preferred values of rated dissipation at 70 °C are:

0,063 W, 0,1 W, 0,16 W, 0,25 W, 0,4 W, 0,63 W, 1 W, 1,6 W, 2,5 W, 4 W, 6,3 W and 10 W.

The derated values of dissipation at temperatures in excess of 70 °C shall be as indicated by the curve as shown in Figure 2.

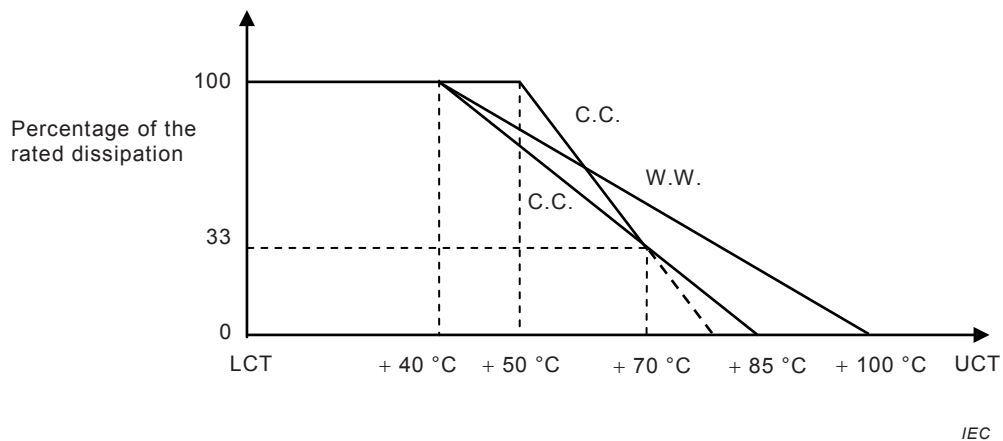


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Figure 2 – Rated dissipation curve

A smaller (or larger) area of operation may be given in the detail specification. In this event the detail specification shall state the maximum allowable dissipation at temperatures other than 70 °C. All break points on the curve shall be verified by test.

An example of derating curve having a smaller area of operation is given in Figure 3.



Key

LCT lower category temperature

UCT upper category temperature

Resistive elements

C.C. carbon composition

W.W. wire-wound

Figure 3 – Rated dissipation curve (examples of smaller area)

2.2.5 Limiting element voltage

The preferred values of limiting element voltage d.c. or a.c. (r.m.s.) are:

100 V, 125 V, 150 V, 200 V, 250 V and 300 V.

2.2.6 Insulation voltage

The detail specification shall state the value of the insulation voltage, rounded off to the nearest 10 V. The numerical value of the insulation voltage shall be:

- normal air pressure: $\geq 1,42$ times the limiting element voltage;
- low air pressure (at 8 kPa): \geq two-thirds the value at normal air pressure.

2.2.7 Switch rating (if applicable)

The preferred ratings for a switch are

- for a.c. voltage (r.m.s.):
1 A to 125 V, 1 A to 250 V, 2 A to 250 V, 3 A to 125 V, and 4 A to 250 V
- for d.c. voltage:
1 A to 250 V.

2.3 Preferred test severities

2.3.1 General

Test severities given in the detail specification shall preferably be selected from the following.

2.3.2 Drying

See IEC 60393-1:2008, 4.3, procedure 1 shall be used.

2.3.3 Vibration

See IEC 60393-1:2008, 4.35, with the following details:

Frequency range: 10 Hz to 55 Hz, or
10 Hz to 500 Hz, or
10 Hz to 2 000 Hz (non-wirewound potentiometers only).

Amplitude: 0,75 mm or acceleration 100 m/s² (whichever is the less severe).

Sweep endurance: total duration: 6 h

The detail specification shall prescribe the mounting method to be used (see 1.3.3).

2.3.4 Shock

See IEC 60393-1:2008, 4.37, with the following details:

Pulse shape: half-sine

Acceleration: 500 m/s²

Pulse duration: 11 ms

Severity: 3 successive shocks to be applied in each of the three directions (total 3 shocks)

The detail specification shall prescribe the mounting method to be used (see 1.3.3).

3 Quality assessment procedures

3.1 General

See IEC 60393-1:2008, Clause H.1.

3.2 Definitions

3.2.1 Primary stage of manufacture

For potentiometers, the primary stage of the manufacture is

- for carbon composition types: the process which produces the greatest change polymerization of the binder;
- for wire-wound types: the winding of the resistance wire (or ribbon) on the mandrel (insulation or insulated);
- for film types: the deposition of the resistive film on the substrate.

3.2.2 Structurally similar components

Potentiometers are considered as being structurally similar if they are produced with similar processes and materials, having the same style and construction and also the same or similar shaft and bush dimensions, though they may have different resistance values and temperature characteristics (or coefficients) of resistance.

3.2.3 Assessment levels EZ and FZ (zero non-conforming)

Assessment levels EZ and FZ meet the requirements of “zero nonconforming” approach. It has been introduced to align the assessment procedures and levels with current industry practices by prescribing the permitted number of nonconforming items (acceptance number) c as zero.

Therefore the sample size for lot-by-lot testing is determined by IEC 61193-2:2007, Table 1.

3.3 Qualification approval

3.3.1 General

The procedures for qualification approval testing are given in IEC 60393-1:2008, Clause H.5.

The schedule to be used for qualification approval testing on the basis of lot-by-lot and periodic test is given in 3.4.

The procedure using a fixed sample size schedule is given in 3.3.2 and 3.3.3 below.

3.3.2 Qualification approval on the basis of the fixed sample size procedure

Sampling

The fixed sample size procedure is described in IEC 60393-1:2008, H.5.3 b). The sample shall be representative of the range of values for which approval is sought. This may or may not be the complete range covered by the detail specification.

The sample shall consist of specimens having the highest and lowest resistance values for which approval is being sought. It should also include the specimens having the critical resistance value, if this is within the range being submitted. When approval is being sought for more than one temperature coefficient (or characteristics) of resistance, the sample shall contain specimens representative of the different temperature coefficients (or characteristics) of resistance. In a similar manner, the sample shall also contain a proportion of specimens of the different resistance values having the closest tolerance for which approval is being sought. The proportion of specimens having the different characteristics shall be proposed by the manufacturers chief inspector and shall be to the satisfaction of a certification body (for example IECQ CB).

Spare specimens are permitted as follows.

- a) One per resistance value and one per each temperature coefficient or temperature characteristics value which may be used to replace the permitted nonconforming items in Group 0.
- b) One per resistance value and one per each temperature coefficient or temperature characteristics value which may be used to replace specimens which are nonconforming because of incidents not attributable to the manufacturer. The number given in Group 0 assume that all groups are applicable.

When additional groups are introduced into the qualification approval test schedule the number of specimens required for Group 0 shall be increased by the same number as that required for the additional groups.

3.3.3 Tests

The complete series of tests specified in Table 6 are required for the approval of potentiometers covered by one detail specification. The tests of each group shall be carried out in the given order.

The whole sample shall be subjected to the tests of Group 0, and then divided for the other groups. Specimens which have passed the non destructive test of Group 4, may be used in other test groups.

Specimens found nonconforming during the test of Group 0 shall not be used for the other groups.

"One nonconforming item" is counted when a potentiometer has not satisfied the whole or a part of the tests of a group.

The approval is granted when the number of nonconforming items does not exceed the specified number of permissible nonconforming items for each group or sub-group and the total number of permissible non-conformances.

In Table 6 the fixed sample size test schedule is given. It includes details of sampling and permissible nonconforming items for different tests or groups of tests and gives, together with the details of the test contained in IEC 60393-1:2008, Clause 4, and Clause 2 of this standard, a complete summary of test conditions and performance requirements.

It is indicated in Table 6 where, for the test methods, test conditions and/or performance requirements, a choice shall be made in the detail specification.

The conditions of test and the performance requirements for the fixed sample size test schedule shall be identical to those prescribed in the detail specification for quality conformance inspection.

Table 6 – Fixed sample size test schedule for qualification approval (1 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
GROUP 0	ND		96 ^h	0	
4.4.1 Visual examination					As in 4.4.1
4.6 Element resistance					Legible marking and as specified in the detail specification
4.4.2 Dimensions (gauging)					As in 4.6.3
4.7 Terminal resistance		Resistance between <u>a</u> to <u>b</u> Resistance between <u>b</u> to <u>c</u>			As specified in the detail specification $R \leq \dots \Omega$ $R \leq \dots \Omega$
4.4.4 Total mechanical travel					See detail specification
4.5 Continuity					As in 4.5.1 and 4.5.2 if applicable
4.15 Rotational noise		Method A (non-wirewound potentiometers only) or Method B or Method C			$\leq \dots$ mV Method B: $\leq \dots$ % or $\dots \Omega$ (whichever is greater) Method C: $\leq \dots \Omega$
4.12 Voltage proof ⁱ (insulated potentiometers only)		Normal air pressure			As in 4.12.5
4.11 Switch contact resistance (if applicable)		After measurement of the switch contact resistance, the switch shall be operated with a load for between 5 and 10 operations			$\leq \dots \Omega$ There shall be a visual indication of the proper functioning of the switch
Spare specimens		5			
GROUP 1	D		12	0	
4.18 Starting torque					As specified in the detail specification
4.31.1 Sealing – Shaft and panel sealing ^c					As in 4.31.1 or Clause A.2 of this standard
4.31.3 Sealing – Container sealing ^c					As in 4.31.3 or Clause A.1 of this standard
4.32 Solderability (if applicable)	Solder bath method: Temperature and duration: SnPb: (235 ± 5) °C, (2 ± 0,5) s SnAgCu: (245 ± 5) °C, (3 ± 0,3) s or Soldering iron method: Solder iron: Size B Temperature: 350 °C ± 10 °C Duration: 2 s to 3 s			Good tinning as evidenced by free flowing of the solder with wetting of the terminals	

Table 6 (2 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
4.45 Solvent resistance of the marking (if applicable)		Solvent: ... Solvent temperature: ... Method 1 Rubbing material: cotton wool			See detail specification Legible marking
4.21 Locking torque (if applicable)		Output voltage ratio			$\Delta \frac{U_{ab}}{U_{ac}} \leq \dots \%$
4.20 End stop torque		Visual examination			As in 4.21.3
4.22 Thrust and pull on shaft		Visual examination - Three specimens As specified in 4.22.2			As in 4.20.1 As in 4.22.2
		Continuity -Three specimens As specified in 4.22.3			$\Delta \frac{U_{ab}}{U_{ac}} \leq \dots \%$
		Setting stability (output voltage ratio) (as in 4.17.2.1) -Two specimens As specified in 4.22.4 Visual examination			As in 4.22.4
4.40 Mechanical endurance (potentiometers) ^d		Number of cycles:... Rate:...cycles per minute Visual examination Element resistance Starting torque Rotational noise: Method A (non-wirewound potentiometers) or Method B or Method C			As in 4.40.6 $\Delta R \leq \pm(\dots \% + \dots \Omega)$... mN·m to ... mN·m $\leq \dots \text{ mV}$
		Sealing (if applicable) - As specified in 4.31.3 or Clause A.1 of this standard (container sealed potentiometers only) - As specified in 4.31.1 or Clause A.2 of this standard			Method B: $\leq \dots \%$ or $\dots \Omega$ (whichever is greater) Method C: $\leq \dots \Omega$
4.41 AC endurance testing on mains switches on capacitive load ^{d,k}		Visual examination Contact resistance Temperature rise Insulation resistance Voltage proof, proof voltage: ... V r.m.s.			As in 4.31.3 or Clause A.1 of this standard As in 4.31.1 or Clause A.2 of this standard As in 4.41.5 $\leq \dots \text{ m}\Omega$ $\leq \dots \text{ }^\circ\text{C}$ $\geq \dots \text{ M}\Omega$ No breakdown or flashover

Table 6 (3 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
4.42 Mechanical endurance ^{d,k} (switch if fitted)		Visual examination Switch contact resistance Switch torque Insulation resistance (insulated potentiometers only) ^j Voltage proof (insulated potentiometers only) ^j			As in 4.42.2.1 ≤ ... mΩ Greater than twice the value of starting torque measured at the beginning of this group and less than 200 mN·m ≥ 1 GΩ As in 4.42.2.5
GROUP 2	D		24	0	
4.30 Robustness of terminals 4.33 Resistance to soldering heat (if applicable) 4.44 Component solvent resistance (if applicable)		The tests appropriate to the type of terminal Visual examination Element resistance Solder bath method: Temperature: 350 °C ± 10 °C Duration: 3,5 s ± 0,5 s or Soldering iron method: Soldering iron: size A Temperature: 350 °C ± 10 °C Duration 10 s ± 1 s Element resistance Terminal resistance: Resistance between <u>a</u> to <u>b</u> Resistance between <u>b</u> to <u>c</u> Solvent: ... Solvent temperature: ... Method 2 Recovery: ...	(12 of the sample)	0	As in 4.30.8 $\Delta R \leq \pm(\dots \% R + \dots \Omega)$ $\Delta R \leq \pm(\dots \% R + \dots \Omega)$ ≤ ... Ω ≤ ... Ω See detail specification

Table 6 (4 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
4.34 Change of temperature ^{e, k}		<p>T_A = Lower category temperature</p> <p>T_B = Upper category temperature</p> <p>Visual examination</p> <p>Setting stability (output voltage ratio) (as in 4.17.2.1)</p>	(Other 12 of sample)	0	<p>As in 4.34.5</p> $\Delta \frac{U_{ab}}{U_{ac}} \leq \dots \%$ $\Delta R \leq \pm(\dots \% + \dots \Omega)$
4.37 Shock		<p>Element resistance</p> <p>For mounting method, see detail specification</p> <p>Pulse shape: half sine</p> <p>Acceleration: 500 m/s²</p> <p>Pulse duration: 11 ms</p> <p>Visual examination</p> <p>Setting stability (output voltage ratio) (as in 4.17.2.1)</p>			<p>As in 4.37.3</p> $\Delta \frac{U_{ab}}{U_{ac}} \leq \dots \%$ $\Delta R \leq \pm(\dots \% + \dots \Omega)$
4.35 Vibration ^{e, f}		<p>Element resistance</p> <p>For mounting method see detail specification</p> <p>Frequency range: ...Hz to...Hz</p> <p>Amplitude: 0,75 mm or acceleration 100 m/s² (whichever is the less severe)</p> <p>Total duration: 6 h</p>			<p>There shall be no discontinuity >100 μs</p>
- Measurements during test		Electrical continuity (as specified in 4.35.4)			
- Final measurements		<p>Visual examination</p> <p>Setting stability (output voltage ratio (preset type only) (as in 4.17.2.1)</p>			<p>As in 4.35.5</p> $\Delta \frac{U_{ab}}{U_{ac}} \leq \dots \%$ $\Delta R \leq \pm(\dots \% + \dots \Omega)$
4.38 Climatic sequence - Dry heat		Visual examination	24	0	As in 4.38.2.2

Table 6 (5 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
<ul style="list-style-type: none"> - Damp heat, cyclic, Test Db, first cycle - Cold - Low air pressure - Damp heat, cyclic, test Db, remaining cycles - DC load ^g - Insulation voltage ^g - Final measurements 		Starting torque Switch torque (if applicable) 8,0 kPa Voltage proof (insulated potentiometers only) ⁱ As in 4.38.7 Visual examination Element resistance Insulation resistance (insulated potentiometers only) ⁱ Switch contact resistance (if applicable) Continuity Starting torque Voltage proof (insulated potentiometers only) ⁱ			... mN·m to ... mN·m ≤400 mN·m As in 4.38.5.3 As in 4.38.8 As in 4.38.10.1 $\Delta R \leq \pm(\dots \% + \dots \Omega)$ $\geq 100 \text{ M}\Omega$ $\leq \dots \text{ m}\Omega$ As in 4.5.1 and 4.5.2 (if applicable) ... mN·m to ... mN·m As in 4.38.10.7
GROUP 3 4.43.2 Electrical endurance at 70 °C	D	Duration: 1 000 h - Loaded between <u>a</u> and <u>c</u> Examination at 48 h, 500 h and 1 000 h: Visual examination Element resistance - Loaded between <u>a</u> and <u>b</u> Examination at 48 h, 500 h and 1 000 h: Visual examination Resistance between <u>a</u> and <u>b</u> Element resistance	12	0	As in 4.43.2.6 a) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ As in 4.43.2.6 a) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ $\Delta R \leq \pm(\dots \% + \dots \Omega)$

Table 6 (6 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
		Insulation resistance (insulated potentiometers only) ⁱ			≥1 GΩ
GROUP 4	ND		12	0	
4.4.4 Total mechanical travel					As specified in the detail specification
4.4.6 Effective electrical travel		Angle of effective electrical travel			≥ ... °
		Angle of ineffective travel (counter-clockwise)			≤ ... °
		Angle of ineffective travel (clockwise)			≤ ... °
4.9 Resistance law	(The detail specification shall prescribe the appropriate test conditions and performance requirements to be selected from 2.1.6 of this standard.)				
4.4.3 Dimensions (detail)					As specified in the detail specification
GROUP 5	D		12	0	
4.39 Damp heat, steady state		1) As in 4.39.2.1 1 st group: 4 specimens 2 nd group: 4 specimens 3 rd group: 4 specimens			
		2) As in 4.39.2.2 1 st group: 6 specimens 2 nd group: 6 specimens			
		DC load ^g			
		Insulation voltage ^{g,i}			As in 4.39.4
- Final measurements		Visual examination			As in 4.39.6.1
		Element resistance			$\Delta R \leq \pm(\dots \% + \dots \Omega)$
	Insulation resistance (insulated potentiometers only) ⁱ	>100 MΩ			
	Switch contact resistance (if applicable)	≤ ... mΩ			
	Continuity (if applicable)	As in 4.5.1 and 4.5.2			

Table 6 (7 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
		Starting torque Rotational noise Method A (non-wirewound potentiometers) or Method B or Method C Voltage proof (insulated potentiometers only) ⁱ			... mN·m to ... mN·m ≤ ... mV Method B: ≤ ... % or ... Ω (whichever is greater) Method C: ≤ ... Ω As in 4.39.6.8
GROUP 6 4.43.3 Electrical endurance at upper category temperature (if applicable) ^f	D	Duration: 1 000 h -Loaded between <u>a</u> and <u>c</u> : Examination at 48 h, 500 h and 1 000 h: Visual examination Element resistance – Loaded between <u>a</u> and <u>b</u> : Examination at 48 h, 500 h and 1 000 h: Visual examination Resistance between <u>a</u> and <u>b</u> Element resistance Examination at 1 000 h Insulation resistance (insulated potentiometers only) ⁱ	12	0	As in 4.43.3.7 a) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ As in 4.43.3.7 a) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ $\Delta R \leq \pm(\dots \% + \dots \Omega)$ $\geq 1 \text{ G}\Omega$
GROUP 7 4.14 Temperature characteristic of resistance	ND	Lower category temperature/20 °C 20 °C/70 °C 20 °C /Upper category temperature	12	0	$\frac{\Delta R}{R} \leq \dots \%$ $\frac{\Delta R}{R} \leq \dots \%$ $\frac{\Delta R}{R} \leq \dots \%$
GROUP 8 4.43 Electrical endurance at temperatures other than 70 °C (if applicable) ^h	D	(This sub-group is only applicable if a derating curve other than the one shown in 2.2.4 of this standard is claimed in the detail specification.) Duration: 1 000 h	12	0	

Table 6 (8 of 8)

Subclause number and test ^a	D or ND ^b	Conditions of test ^a	Sample size and criterion of acceptability ^b		Performance requirements ^a
			<i>n</i>	<i>c</i>	
		- Loaded between <u>a</u> and <u>c</u> : Examination at 48 h, 500 h and 1 000 h: Visual examination Element resistance - Loaded between <u>a</u> and <u>b</u> : Examination at 48 h, 500 h and 1 000 h: Visual examination Resistance between <u>a</u> and <u>b</u> Element resistance Examination at 1 000 h Insulation resistance (insulated potentiometers only) ⁱ			As in 4.43.1.6 a) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ (As for Group 3) As in 4.43.1.6 a) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ (As for Group 3) $\Delta R \leq \pm(\dots \% + \dots \Omega)$ $\geq 1 \text{ G}\Omega$
<p>^a Subclause numbers of test and performance requirements refer to IEC 60393-1:2008, except for some severities for environmental tests and limits of change in resistance or output ratio, which shall be taken from the relevant clauses of this sectional specification.</p> <p>^b In this table: <i>n</i> = the sample size <i>c</i> = group acceptance criterion (permitted number of defectives per group). D = destructive ND = non-destructive</p> <p>^c The sealing tests applicable to the construction of the potentiometers shall be applied. The tests for Type A seals (4.31.1) and Type B seals (4.31.2.1) may be performed as a single test in the case of shaft and panel sealed potentiometers.</p> <p>^d The mechanical endurance tests for potentiometers and switches shall be performed as a single test if switches are fitted to the potentiometers.</p> <p>^e If applicable, the requirements for preset potentiometers shall also apply.</p> <p>^f This test is applicable only to potentiometers with climatic category 25/-/-, 40/-/-, 55/-/- and 65/-/-.</p> <p>^g The d.c. load test and the insulation voltage test are considered to be alternatives. The detail specification shall indicate which test applies.</p> <p>^h The sample size in Group 0 shall be increased by 12 specimens if Group 8 is applicable.</p> <p>ⁱ For method of mounting, see IEC 60393-1:2008, 4.12 or 4.13, as appropriate, with the following details: 1) Components designed as "mounted by body" shall be mounted as in 4.12.1. 2) Components designed as "mounted by terminations" shall be tested whilst mounted by their terminations on a printed board, irrespective of whether any holes exist which could permit mounting by the body.</p> <p>^j For the mounting method, the detail specification shall describe which test is selected: 4.41 or 4.42.</p> <p>^k This test is applicable only if the temperature difference between the upper and lower category temperatures is equal to or greater than 95 °C.</p>					

3.4 Quality conformance inspection

3.4.1 Formation of inspection lots

An inspection lot shall consist of structurally similar potentiometers (see 3.2.2). In addition, the following details are applicable:

- a) Groups A and B: These tests shall be carried out lot-by-lot and the resistance values shall be representative of the production.
- b) Group C
 - 1) The sample shall be collected over 13 weeks.
 - 2) The sample shall be representative of the range of resistance values produced during this period.
- c) Group D: As Group C, except that the sample shall be collected over the last 13 weeks of the inspection period.

There shall be satisfactory balance between high, low and critical resistance values in the samples taken.

3.4.2 Test schedule

The schedule for the lot-by-lot and periodic tests for quality conformance inspection is given in Table 2 of the blank detail specification.

3.4.3 Assessment levels

The assessment level(s) given in the blank detail specification shall preferably be selected from Table 7 and Table 8:

Table 7 – Quality conformance inspection: Lot-by-lot (1 of 2)

Assessment level EZ				Assessment level FZ					
Inspection subgroup ^d	IL ^a	n ^a	c ^a	Inspection subgroup ^d	IL ^a	n ^a	c ^a		
4.6 A0 Element resistance	100 % ^b			4.6 A0 Element resistance	100 % ^b				
4.4.1 A1 Visual examination	II	c	0	4.4.1 A1 Visual examination	S-3	c	0		
4.4.2 A2 Dimensions ^e (gauging)	S-2	c	0	4.15 A2 Rotational noise	S-3	c	0		
4.4.4 A3 Total mechanical travel	S-2	c	0						
4.7 A4 Terminal resistance	S-2	c	0						
4.5 Continuity									
4.15 Rotational noise									
4.12 Voltage proof									
4.11 Switch contact resistance (if applicable)									

Assessment level EZ				Assessment level FZ			
Inspection subgroup ^d	IL ^a	<i>n</i> ^a	<i>c</i> ^a	Inspection subgroup ^d	IL ^a	<i>n</i> ^a	<i>c</i> ^a
B1 4.18 Starting torque 4.31 Sealing (if applicable)	S-2	^c	0	B1 4.12 Voltage proof 4.32 Solderability 4.45 Solvent resistance of the marking (if applicable)	S-2	^c	0
B2 4.32 Solderability (if applicable) 4.45 Solvent resistance of the marking (if applicable)	S-2	^c	0	B2 4.7 Terminal resistance 4.9 Resistance law	S-2	^c	0
<p>^a IL = inspection level <i>n</i> = the sample size <i>c</i> = permissible number of nonconforming items</p> <p>^b This inspection shall be performed after removal of nonconforming items by 100 % testing during the manufacturing process. Whether the lot was accepted or not, all of samples for sampling inspection shall be inspected in order to monitor outgoing quality level by nonconforming items per million ($\times 10^{-6}$). The sampling level shall be established by the manufacturer, preferably according to IEC 61193-2:2007, Annex A.</p> <p>In case one or more nonconforming items occur in a sample, this lot shall be rejected but all nonconforming items shall be counted for the calculation of quality level values.</p> <p>If applicable, outgoing quality level by nonconforming items per million ($\times 10^{-6}$) values shall be calculated by accumulating inspection data according to the method given in IEC 61193-2:2007, 6.2.</p> <p>^c Number to be tested: Sample size shall be determined according to IEC 61193-2:2007, 4.3.2.</p> <p>^d The content of the inspection subgroups is described in Clause 2 of relevant blank detail specification.</p> <p>^e This test may be replaced by in-production testing if the manufacturer installs statistical process control (SPC) on dimensional measurements or other mechanisms to avoid that any parts exceed the dimensional limits.</p>							

Table 8 – Quality conformance inspection: Periodic testing

Assessment level EZ				Assessment level FZ			
Inspection subgroup ^b	<i>p</i> ^a	<i>n</i> ^a	<i>c</i> ^a	Inspection subgroup ^b	<i>p</i> ^a	<i>n</i> ^a	<i>c</i> ^a
C1	3	12	0	C1	3	8	0
4.21 Locking torque (if applicable)				4.4.2 Dimensions (gauging)			
4.20 End stop torque				4.4.4 Total mechanical travel			
4.22 Thrust and pull on shaft				4.30 Robustness of terminals			
4.4.4 Total mechanical travel							
4.4.6 Effective electrical travel							
4.9 Resistance law							
C2	3	24	0	C2	3	8	0
C2A (Part of the sample)	3	12	0	4.18 Starting torque			
4.30 Robustness of terminals				4.19 Switch torque			
4.33 Resistance to soldering heat (if applicable)							
4.44 Component solvent resistance (if applicable)							
C2B (Part of the sample)	3	12	0				
4.34 Change of temperature							
4.37 Shock							
4.35 Vibration							
C2	3	24	0				
(Combined sample of C2A and C2B)							
4.38 Climatic sequence							
C3	6	12	0	C3	6	8	0
4.40 Mechanical endurance (potentiometers)				4.40 Mechanical endurance (potentiometers)			
4.41 AC endurance testing of mains switches on capacitive load				4.41 AC endurance testing of mains switches on capacitive load			
or				or			
4.42 Mechanical endurance (switch if fitted)				4.42 Mechanical endurance (switch if fitted)			

Assessment level EZ				Assessment level FZ			
Inspection subgroup ^b	<i>p</i> ^a	<i>n</i> ^a	<i>c</i> ^a	Inspection subgroup ^b	<i>p</i> ^a	<i>n</i> ^a	<i>c</i> ^a
C4 4.43.2 Electrical endurance at 70 °C	6	12	0	C4 4.43.2 Electrical endurance at 70 °C	6	8	0
D1 4.39 Damp heat, steady state	12	12	0	D1 4.39 Damp heat, steady state	12	8	0
D2 4.43.3 Electrical endurance at upper category temp. (if applicable) 4.42 Mechanical endurance (switch if fitted)	36	12	0	D2 4.4.4 Total mechanical travel 4.4.6 Effective electrical travel 4.9 Resistance law	12	8	0
D3 4.14 Temperature characteristic of resistance	36	12	0	D3 4.21 Locking torque (if applicable) 4.20 End stop torque 4.22 Thrust and pull on shaft	12	8	0
D4 4.4.3 Dimensions (detail)	36	12	0	D4 4.14 Temp. characteristic of resistance	24	8	0
D5 4.43 Electrical endurance at temperatures other than 70 °C (if applicable)	36	12	0	D5	24	12	0
				D5A (Part of the sample)	24	6	0
				4.33 Resistance to soldering heat (if applicable)			
				4.44 Component solvent resistance (if applicable)			
				D5B (Part of the sample)	24	6	0
				4.34 Change of temperature 4.35 Vibration			
D5 (Combined sample D5A and D5B)	24	12	0				
4.30 Robustness of terminals 4.37 Shock 4.38 Climatic sequence							
<p>If one nonconforming item is obtained, all the tests of subgroup shall be repeated on a new sample and then no further nonconforming items are permitted. Release of product may continue during repeat testing.</p> <p>^a <i>p</i> = periodicity in months <i>n</i> = the sample size <i>c</i> = permissible number of nonconforming items</p> <p>^b The content of the inspection subgroups in Clause 2 of the relevant blank detail specification.</p>							

3.5 Delayed delivery

The provisions of IEC 60393-1:2008, Clause H.10, shall apply, except that the inspection level shall be reduced to S-2.

The period for carbon composition potentiometers shall be one year.

Annex A (normative)

Test methods for sealing

A.1 Container sealing test for container sealed styles only

The components shall be submerged in water to depth of approximately 75 mm in a chamber in which the pressure shall be reduced to 16 kPa.

Requirements: There shall be no leakage of air from the interior of the components as indicated by bubbles.

A.2 Shaft and panel sealing test for all styles

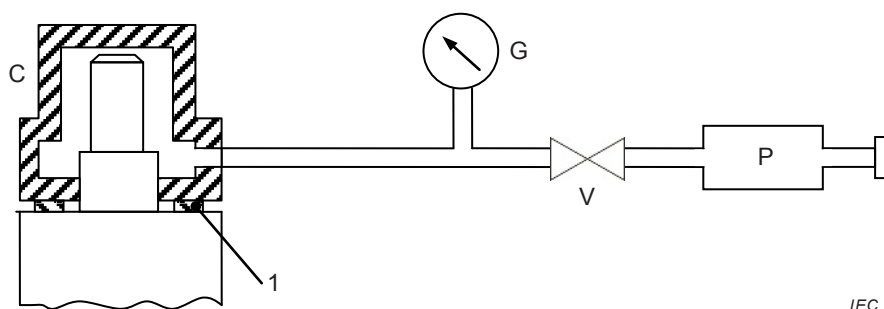
A suitable apparatus is illustrated diagrammatically in Figure A.1. It is intended only for indicating whether seals are incorrectly fitted or damaged and not for measuring rates of leakage.

“C” is a small chamber shown in section, which can be evacuated by means of the pump “P” through a control valve “V” to an extent indicated by the gauge “G”.

The sensitivity of the apparatus depends upon the volume of the free space in the chamber when the component under test is fitted. This free space should be such that an initial pressure of 16,7 kPa will be reduced to at least 13,3 kPa when the volume is increased by 10 ml. This requirement involves a maximum free air space, including that in the pipe line and gauge of 40 ml.

The component to be tested is mounted in a normal manner for panel mounting with a panel seal, except that it needs not be secured with the securing nut and washer, with the controlling end of the shaft within the chamber. The chamber is then evacuated to approximately 4,8 kPa and valve “V” is closed.

Requirements: There shall be no observable change of pressure during 10 s.



Key

- 1 panel seal
- C small chamber
- G gauge
- P pump
- V valve

Figure A.1 – Component under test

Bibliography

IEC 60410:1973, *Sampling plans and procedures for inspection by attributes*

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